

## Connectors for electronic equipment –

### Part 3-104:

Detail specification for 8-way, shielded free  
and fixed connectors for data transmissions  
with frequencies up to 600 MHz minimum

**PUBLICLY AVAILABLE SPECIFICATION**



INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION

Reference number  
IEC/PAS 61076-3-104

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# INTERNATIONAL ELECTROTECHNICAL COMMISSION

## CONNECTORS FOR ELECTRONIC EQUIPMENT –

### Part 3-104: Detail specification for 8-way, shielded free and fixed connectors for data transmissions with frequencies up to 600 MHz minimum

#### FOREWORD

A PAS is a technical specification not fulfilling the requirements for a standard, but made available to the public.

IEC-PAS 61076-3-104 has been processed by subcommittee 48B: Connectors, of IEC technical committee 48: Electromechanical components and mechanical structures for electronic equipment.

The text of this PAS is based on the following document:

This PAS was approved for publication by the P-members of the committee concerned as indicated in the following document:

Draft PAS	Report on voting
48B/1167/PAS	48B/1215A/RVD

Following publication of this PAS, the technical committee or subcommittee concerned will investigate the possibility of transforming the PAS into an International Standard.

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## CONNECTORS FOR ELECTRONIC EQUIPMENT –

### Part 3-104: Detail specification for 8-way, shielded free and fixed connectors for data transmissions with frequencies up to 600 MHz minimum

#### 1 General

##### 1.1 Scope

This part of IEC 61076 establishes uniform specifications, type testing requirements and quality assessment procedures for 8 ways connectors, with up to 4 pairs, for frequencies up to 600 MHz minimum, and intended to be used at different locations within cabling for ICT, home entertainment and multimedia. It contains a choice of all test methods and sequences, severity and preferred values for dimensions and characteristics.

##### 1.2 Normative references

The following normative documents contain provisions that, through reference in this text, constitute provisions of this part of IEC 61076. At the time of publication, the editions indicated were valid. All normative documents are subject to revision, and parties to agreements based on this part of IEC 61076 are encouraged to investigate the possibility of applying the most recent editions of the normative documents listed below. Members of IEC and ISO maintain registers of currently valid International Standards.

IEC 60352-2:1990, *Solderless connections – Part 2: Solderless crimped connections – General requirements, test methods and practical guidance*

IEC 60352-3:1993, *Solderless connections – Part 3: Solderless accessible insulation displacement connections – General requirements, test methods and practical guidance.*

IEC 60352-4:1994, *Solderless connections – Part 4: Solderless non-accessible insulation displacement connections – General requirements, test methods and practical guidance*

IEC 60352-6:1994, *Solderless connections – Part 6: Insulation piercing connections – General requirements, test methods and practical guidance*

IEC 61076-1:1995, *Connectors with assessed quality, for use in d.c., low frequency analogue applications and in digital high speed data application – Part 1: Generic specifications – Capability approval*

ISO/IEC 11801 *Information technology – Generic cabling for customer premises*

IEC 60068-1 *Environmental testing. Part 1: General and guidance*

IEC 60603-7 *Connectors for frequencies below 3 MHz for use with printed boards – Part 7: Detail specification for connectors, 8-way, including fixed and free connectors with common mating features, with assessed quality*

IEC 60512-1 *Electromechanical components for electronic equipment, Basic testing procedures and measuring methods – Part 1: General*

IEC 60512-2 *Electromechanical components for electronic equipment, basic testing procedures and measuring methods – Part 2: General examination, electrical continuity and contact resistance tests, insulation tests and voltage stress tests*

IEC 60512-3 *Electromechanical components for electronic equipment; basic testing procedures and measuring methods – Part 3: Current-carrying capacity tests*

IEC 60512-4 *Electromechanical components for electronic equipment; basic testing procedures and measuring methods – Part 4: Dynamic stress tests*

IEC 60512-5 *Electromechanical components for electronic equipment; basic testing procedures and measuring methods – Part 5: Impact tests (free components), static load tests (fixed components), endurance tests and overload tests*



IEC 60512-6 *Electromechanical components for electronic equipment; basic testing procedures and measuring methods – Part 6: Climatic tests and soldering tests*

IEC 60512-7 *Electromechanical components for electronic equipment; basic testing procedures and measuring methods – Part 7: Mechanical operating tests and sealing tests*

IEC 60512-8 *Electromechanical components for electronic equipment; basic testing procedures and measuring methods – Part 8: Connector tests (mechanical) and mechanical tests on contacts and terminations*

ISO 1302 *Technical Drawings – Method of indicating surface texture*

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